Optical calibration of the E-ELT adaptive mirror M4: testing protocol and assessment of the measurement accuracy

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ABSTRACT

The M4U is the adaptive mirror of the European Extremely Large Telescope (E-ELT), composed by six thin shell segments and controlled by 5136 voice coil actuators. During the project phase C we addressed the concept of the optical calibration and verification of the mirror; the outcome of such study is a testing protocol on the large facility named Optical Test Tower (OTT). In this work we give an overview of the test facility and of the calibration concept; then we present the analysis results, with a particular focus on the environmental noise (e.g., convection and thermal drifts), procedure criticities and processing errors. In the end we summarize their impact on the requirements verification of the adaptive mirror. The M4U project is led by the Italian consortium AdOptica under an ESO contract.

Keywords: Adaptive Optics, Wavefront correctors, Deformable mirrors, Optical calibration, Simulation

1. INTRODUCTION: THE M4U AND ITS TESTING FACILITY

The M4U is a 2.54 m diameter mirror composed by six petal segments. The optical surface is a 2 mm thick Zerodur glass shell, actively shaped at 1 kHz by 5136 voice-coil motors, which are in turns controlled in close loop by capacitive position sensors. The working principle and control strategy, inherited from the LBT and VLT-UT4 adaptive secondaries, have been extensively assessed during the testing and commissioning of these systems and are described in.\textsuperscript{1} The M4U is a flat mirror and therefore a large collimator is required for the interferometric measurements. The optical setup is based on a 4D Technology Twyman-Green vibration insensitive interferometer producing a F/3.3 beam which is then collimated by a parabolic mirror to illuminate the M4U. Due to encumbrance requirements, the parabolic collimator (PAR) is smaller that the M4U diameter and allows the measurement of a single segment at a time; such setup is named LAI (large aperture interferometry). An additional optical system named SAI (Sub aperture interferometry) is composed by a 100 mm diameter lens collimator to allow the direct measurement of the high spatial frequencies. A 60 cm diameter flat mirror (RF) acts as a reference surface to allow the optical alignment of both parabola and M4U. A detailed description of the optical design and its optimization strategy is given in,\textsuperscript{2} these proceedings.

2. OPTICAL CALIBRATION OF THE ADAPTIVE MIRROR

2.1 Measurement protocol

We developed the test plan starting from the past activities with the LBT\textsuperscript{3} and VLT\textsuperscript{4} deformable mirrors (DM). During these tests, the optical calibration procedure for monolithic mirrors (i.e., single segment) has been refined; the calibration of a segmented system including segments management, correction of differential alignment and
co-phasing has been extensively addressed during the optical measurements of the M4 prototype M4DP. Within the present scope we will recall the main points of the optical calibration protocol, with the goal to frame the analysis strategy and the measurement budget.

The preliminary mirror flattening consists in the identification of a set of actuator commands to have the whole mirror surface within the interferometer capture range. Then, it is possible to collect the mirror modes (modal and zonal influence functions) required to complete the flattening procedure and the correction of the high order modes. Alignment aberrations, like piston and tip-tilt, are not corrected at this point. A great attention shall be paid at this stage to avoid correcting the alignment modes like coma, focus and spherical aberration with the M4U surface. The calibration of the capacitive sensors, co-located with the actuators, is also performed with a procedure run separately for each shell. At this step, the presence of neighbour non-active shells may be used for the correction of vibration noise on the measurement area. At the end of the process, the single shells are individually flattened. In order to co-phase all the segments, differential tip/tilt and piston is corrected with the following procedure: the OTT is configured as to image the central part of the M4U (see Fig. 2, bottom panel) and the local tip/tilt is removed; then, the differential piston is measured with a dedicated Sensor of Phase Lag (SPL) to remove the lambda ambiguity of the interferometric measurements; in the end the final phasing is completed with the interferometer, with a goal phasing accuracy of 20 nm RMS wavefront.

The verification of the requirements will be performed after the flattening and phasing of the whole M4 mirror. The verification measurements include the WFE, both global (full aperture) and local (interactuator pitch), co-phasing error, slope RMS, local curvature and accuracy of the application of low order Zernike commands.

2.2 Analysis strategy

The strategy for the analysis of the measurement accuracy is described extensively in. He we recall that we considered three main steps:

- the identification of the measurement types requested for the calibration and performance verification routines: more specifically they are differential samplings (for instance to measure with the push-pull technique the actuators influence functions) and absolute samplings, to acquire the current mirror WF map for the flattening or as a verification measurement;
the identification of the error sources specifically affecting each measurement type, according to the test conditions;

- the noise propagation, including the processing errors, to compute the final measurement budget.

In the following we describe the error sources and the method to assess their individual contribution. In the end we take into account the testing protocol and perturb it with the expected noise values, to budget the final measurement accuracy. Such task, corresponding to an end to end simulation, has been performed with 8s, the simulator of the OTT with M4, specifically designed to assess the calibration protocol.

### 3. Expected Measurement Noise Sources

#### 3.1 Interferometer CCD noise

We evaluated it by means of a direct measurement on our interferometer on the optical bench: we closed the cavity with a small flat mirror in front of the exit pupil and collected 2048 frames; then we computed the 1024 differential images to reject the static WF from the cavity; at last we measured for each couple the standard deviations \( \sigma_W \) and \( \sigma_s \) of the WF and of the slope, respectively.

The frames are statistically uncorrelated, then we can take \( \epsilon = \sqrt{2} \left< \sigma \right> \) as an estimator for the measurement repeatability when collecting a single frame. For the WFE case we obtained \( \epsilon \sim 2 \text{ nm} \), corresponding to 2 bit (with a 10 bit resolution the sample the 632 nm phase lag). In terms of slope error, such value corresponds to 0.06 arcsec RMS.

From these value we can calculate the number of frames to average together in order to achieve a target error. The average of a large number of frames is also requested to reduce the noise input from (e.g.) air convection, so that we considered the CCD noise already included in the error value from convection.

#### 3.2 Air convection

We considered a procedure for the characterization of the actual convection noise from real data collected in relevant environments. We took such results, in terms of global WFE (or piston error, slope error, etc) versus sampling parameters, as the expected OTT convection noise; such values are then scaled according to the final sampling procedure. The convection noise budget is then converted into a sampling parameters budget. Operatively, we considered a number of interferometer datasets composed by 1000 frames collected at 25 Hz. They have been collected during the optical test of the M4DP in different environmental conditions, e.g.: ventilation fans on/off, vertical temperature gradient positive/negative, optical bench open/closed. Such conditions fill the possible environment parameters space for an optical test environment and are a good representation of a typical case scenario. We also compared these data with equivalent samplings collected in different laboratories, with similar conditions, obtaining scalable results.

We will consider in the following two test cases, for absolute or differential acquisition. The allocated convection budget will be given case by case for each specific requirement.

##### 3.2.1 Absolute measurements

Absolute measurements are collected to sample the current shape of the M4U, for instance during the flattening process or its verification. The convection noise in absolute measurements is assessed by measuring its coherence time via the sampling of the noise structure function. The knowledge of the structure function allows the computation of the number of frames and of the frame rate to obtain a given noise threshold.

The test dataset composed by \( n \) frames is analyzed to evaluate the WFE temporal structure function, representing the convection pattern evolution in time. The goal is to estimate the frame rate and number for a robust averaging. More details on the computation are given in. In Fig. 3 we show a sample of convection structure functions collected with different environment conditions.

For each plot, the asymptotic value \( v \) represents the noise expected after averaging two statistically uncorrelated realizations. Then the single frame expected noise is \( v \sqrt{2} \). In order to obtain a residual noise \( v_0 \), the number of frames to be average together is computed as \( n = \left( v \sqrt{2} / v_0 \right)^2 \). Such computation is valid if the samples are statistically uncorrelated, i.e. if convection has fully evolved during the time gap between them. The coherence
time $\tau$ is evaluated by finding the knee of the dataset. Two frames are statistically uncorrelated if they are collected after a time $2\tau$.

Once the sampling parameters have been found, we computed the average of $n$ uncorrelated frames and measured on the averaged image the slope error and the local curvature. From the associated plots, we may estimate the requested number of frames and the total sampling time to achieve the allocated error budget. The same procedure may be run to estimate the optimal sampling parameter for differential piston measurements.

### 3.2.2 Convection noise in differential measurements

Differential sampling is requested to measure the DM response to a given command of amplitude $a$: for instance it is used to calibrate e.g. the actuators IF, mirror modes IF, capsens calibration. We refer to these cases as differential samplings because data are collected with the push-pull technique, i.e. opposite commands are applied and recorded as WF map difference. The noise from air convection shall be evaluated to estimate the amplitude $a$ or the integration time to achieve a given SNR. The analysis procedure consists in running the differential algorithm on a dataset containing a static WF map, i.e. no commands are applied to the DM. We can then plot the expected differential WFE versus the number of $n$ differences averaged together.

The result for the M4DP case is shown in the picture below. Each plot represents a different environment condition (as presented above). As expected, the best SNR is achieved with a thermalized optical bench and no air ventilation. As a comparison, the worst case scenario (i.e. with non-thermalized bench and forced air flux) leads to a doubled noise level; in this case we need a 4x larger integration to preserve the SNR.

These results are achieved with a frame rate of 25 Hz; faster frame rates yield a better subtraction of correlated feature and a larger SNR.

**Figure 3. Convection structure function on DP test bench**

**Figure 4. Effect of averaging on differential frames WFE (M4DP case)**

### 3.3 Thermal drift

The analysis is based on the opto-mechanical simulation of the OTT. First, we computed (by means of ray tracing software) the sensitivity matrix for each optical components, in terms of the Zernike aberrations after perturbing each degree of freedom.

Then we considered the FE model of the OTT and evaluated the thermo-mechanical deformation when subjected to an unitary temperature variation. We considered both the case of a vertical (and horizontal) thermal gradient and the case of a unitary thermal step. For each case, the OTT deformation has been re-mapped in terms of the displacements of the optical components from the interferometer (5 degrees of freedom). The rate of the temperature variation has been estimated experimentally: we measured the temperature variation of a massive crane structure placed in a testing facility and exposed to daily thermal cycle. The maximum measurement
Figure 5. Expected slope error given by air convection versus number of frames averaged.

slope (0.65°C/hour) may be considered as an upper bound for the temperature variation rate; please note that the value is however smaller than the rate expected inside the E-ELT dome.

We also evaluated from the FEM the thermal deformation of the parabolic collimator support, which is responsible for a three-foil shape changing with temperature at a rate of +0.4 nm/C.

At last we computed the total WF map from thermal drift, as the thermal deformation of the parabola plus the Zernike aberration from mis-alignment induced by the optics displacement. As we know the temperature variation rate, such result may be indicated both as WFE vs temperature variation and WFE vs measurement duration. The resulting map is analyzed in terms of global WFE and slope, local curvature and piston error. For the latter, we considered the piston value as the average phase of the OTT map computed within the optical mask of one of the M4U segment (see Fig.2), and evaluated its behaviour at changing the relative orientation segment vs OTT.

Thermal drifts affect absolute measurements only, because of the relatively long time scale of thermal variations (tens of seconds), compared to the typical frame rate for differential samplings (25 Hz).

Figure 6. Expected local curvature error given by air convection versus number of frames averaged.

Figure 7. Expected WFE due to thermal drift, for a temperature step of 1°C.

Figure 8. Mean value over the M4 segment mask of the WFE due to thermal drifts.
3.4 Mechanical vibrations

Mechanical vibrations are responsible for misalignment of the optical components at a relatively high frequency, thus producing low order aberrations of the WF map (tip-tilt, focus and coma). We considered the FE model of the OTT and perturbed it with a vibration spectrum acquired in the test facility in daytime (corresponding to worst case testing conditions) and low-pass filtered according to the dampers transfer function. The dataset has been analytically applied to the FE model to compute the displacement of the optical components and to evaluate the corresponding WFE.

The resulting data have been analyzed according to two pipelines: in one case, we computed the WF map after averaging n frames (simulating absolute samplings); in the other case, we measured the differential WF map at the interferometer frame rate, to evaluate the differential sampling error. For both cases we measured on the final maps the total WFE, slope error, local curvature and local piston within the M4U segment mask.

3.5 Processing error

We evaluated the numerical error associated with the data processing algorithms, for two particular cases. The \textit{tilt-detrend} function identifies the segment masks within an image and compute their individual tilt values. The result is used to remove the vibration tilt, measured on the un-active shell, from the active shell, for instance during push-pull measurements of the mirror influence functions. Alternatively it may be used to evaluate the differential tilt amongst the segments for the final co-phasing.

The \textit{phase-unwarp} algorithm is used to correct the interferometer phase ambiguity from the islands in the WF map, also with the aid of the SPL (see above). A detailed description and validation for both of them is given in.\textsuperscript{5}

For both cases, the processing error has been evaluated by testing the algorithms on WF maps affected by thermal drift and vibration noise.

3.6 Optics manufacturing error

A detailed description of the optics manufacturing error is given in.\textsuperscript{2} The baseline for the testing protocol is to subtract from the M4U WF map the current OTT cavity, which is given mostly by the shape error of the PAR. The subtraction error for such static offset is given by two elements: the pixel-to-pixel alignment between the PAR map and the M4U one and the PAR manufacturing offset. The latter represents the print-through of the null optics (namely a CGH) used in the optical workshop to polish the PAR and accounts for the accuracy error in the calibration shape. The polishing residuals represent on the contrary a precision error. For both contributions we produced a Montecarlo simulation of polishing/null optics errors (representing the parabola) and computed the residual after a rigid shift of 2x2 pixel. The residual map was then corrected with the actuator influence functions to simulate the flattening error. The pupil image relaying optics (RS), which are smaller than 2 inches in diameter, may be calibrated to better than 1 nm WFE RMS and are not considered within this scope. The calibration of the 100 mm SAI optics will be performed with the same technique and it is budgeted to 3 nm RMS.

3.7 Retrace error

The retrace error is produced when the interferometer measures the M4U with a large aberration (tilt, power). Such case applies only during the Zernike test, when large amplitude low order Zernike commands are produced by the actuators. During the other verification measurements, the optical figuring of the M4U is very low. Under this assumption, the retrace error is always negligible except for the case of the Zernike test. Within this context, we modeled with an optical design software the M4 mirror as a Zernike Fringe phase surface, centered on the M4U axis; we analyzed the difference between the surface applied and the one measured. The computed retrace error is always lower than 0.3% of the applied Zernike amplitude. It can be therefore neglected also for the case of the Zernike test.
3.8 Zernike fitting error

The measurement of the Zernike alignment modes (focus and coma) in the OTT is performed using the Reference Flat mirror (RF) as a reference surface. The RF is smaller than the optical surface (0.6 m vs 1.5 m diameter) and this affects the accuracy of the Zernike modes fitting, in particular in presence of a large tilt offset. We computed by simulation the relative accuracy of the fitting to evaluate the maximum error expected during alignment. The test has been performed twice: in a first step, without vibration noise in order to identify the pure fitting accuracy; in a second step, the test was performed considering also the effects of vibrations noise: in this case the initial offset includes the Zernike mode to be measured, as it is injected by the optics displacement because of vibrations. The test took into account different positions of the reference flat. We measured a fit accuracy better than 3, without correlation with the static offset added. This observation may be explained considering that the aperture of the RF, although smaller that the optical area, is large enough to allow a correct spatial sampling of the alignment modes (coma and power), so that the modes fitting is well conditioned. The fitting accuracy term will be therefore neglected from the budgeting.

3.9 Accuracy of the absolute piston sensor

The OTT is fitted with an absolute piston sensor (SPL) to help solving the interferometer phase ambiguity. Here we recall that is composed by an illumination system, a camera and a narrow-band, liquid crystal tunable filter; the working principle has been investigated since many years and a description may be found in. The SPL is requested to verify that the convergence condition is satisfied for the phase ambiguity correction algorithm (see sec.3.5). The final measurement of the differential piston amongst segments is indeed allocated to the interferometer. Therefore, the specification for the SPL is to provide a measurement accuracy within just $\lambda/4$ across a broad capture range; accordingly, the error budget allocated has the same order of magnitude. Its measurement error is given by two terms: first, the intrinsic accuracy of the system as-designed can be evaluated analytically, for instance, the piston accuracy depends on the filter bandwidth (which is known), leading to a piston uncertainty of 120 nm. The second term is the local differential piston on the sensed area given by the differential tilt amongst the segments. We budgeted such contribution considering the datasets collected with the M4DP unit. In that case, the differential tip/tilt between the segments was negligible with respect to the global WFE (20 nm RMS) so that this term may be neglected for the SPL error budget.

4. ERRORS PROPAGATION AND VERIFICATION MEASUREMENTS BUDGET

So far we concluded the exercise of the identification of the noise sources within the optical test bench, together with suitable strategies to assess their contribution. In many cases we converted the error budget into a sampling
parameters budget, such as number of frames, frame rate, total measurement time. We are now able to sum up the individual error sources into the final measurement accuracy budget. For each of the verification measurement cases we will consider the applicable noise contributions, scaled according to the proposed procedure and sampling parameters. Such strategy is presented more in detail in.

4.1 Mirror flattening accuracy

The flattening process consists in the application of the mirror modes to correct the optical surface. The process is in close loop with the interferometer, providing at each step the current surface map $S$ to be flattened. The applicable command is computed by projection of $S$ on to the mirror modes shapes, piled up in the interaction matrix $M$. The flattening accuracy is therefore affected by the errors in both $S$ and $M$; we will however discard the last term, because the individual errors in each vector of the $M$ can be negligible (lower than 1 nm RMS). The errors in the sampling of $S$ comes from measurement noise (precision) and static offset from the optics. For both cases, the individual contributions may be divided according to their spatial scale: signals within the actuator spacing (31 mm) are command offset as they may be produced with the actuators and will be observed regardless the optical system; signals at lower spatial scale affect the verification measurement and will be seen with the current optical configuration only. We will treat both cases together.

We budget the following contributions:

**Convection** Air convection affects the flattening command with a random offset in the surface map $S$. Its contribution may be evaluated as discussed in sec.3.2.1, by computing the expected WFE after averaging $n$ uncorrelated frames. In the present scope, we fixed the acceptable convection WFE to 5 nm RMS and calculated the sampling parameters requested. According to a worst case condition as in Fig.3, the goal WFE is obtained by averaging 225 frames collected at a frame rate of 0.5 Hz. Such computation yields also the total sampling duration $t$.

**Thermal drifts** We computed the thermal deformation occurred during a time step $t$ and considered half of its amplitude as the thermal offset for the surface map $S$. The contribution includes both the misalignment induced by thermal bending of the OTT and the surface deformation of the parabola sitting on its 3 pads.

**Vibrations** We considered the non-averaged misalignment given by vibrations during the time gap $t$, tip/tilt filtered.

**Optics manufacturing** We computed the optics manufacturing error to flattening as indicated in sec.3.6, as the sum of polishing and offset errors. For both cases we considered the print-through on the actuators (as the flattening command offset) and the higher orders residual as the verification measurement error.

**Processing error** We considered the numerical error of the processing algorithms when applied to the expected tilt from non averaged vibrations during the time step $t$.

4.2 Co-phasing accuracy

The co-phasing process is the actuator correction of the rigid modes within the visible area; it consists in the application of piston, tip and tilt commands produced by the actuators on each segment, in order to make them laying on the same plane. For the budgeting of the measurement accuracy, we consider a test area of 50 cm diameter (corresponding to the reference flat mirror aperture) and compute its mean value from the various error sources. We take such measurement as an estimator of the local piston affecting the M4U measurement of phasing. The test accuracy error is given by the following contributors:

**Convection** In Sec.3.2.1 we evaluated the effect of non-averaged convection patterns in terms of mean value over a given subaperture depending on number of frames and frame rate. We consider a target noise value and identify the sampling parameters to achieve that value.

**Thermal drifts** We considered the OTT thermal drift during the measurement time and the associated Zernike modes, namely power and coma; we then computed the mean value of the alignment aberrations over the test area.
Vibrations It affects the piston measurement as the tip-tilt mode measured out of center has a non zero mean value. We evaluated such contributions from the residual misalignment induced by vibration, as it has been described in sec.3.4.

Optics manufacturing We computed its contribution as the mean value over the test aperture of the Monte-carlo realizations of the manufacturing offset as discussed in sec.3.6.

Processing error We considered the mean value over the test aperture of the numerical residues of the processing algorithms. We tested them with a WF map given by the non averaged vibration after a time gap $t$.

4.3 Surface slope error

The measurement of the surface slope error is performed on the flattened M4U, segment by segment, after correcting for the OTT alignment. Then the surface map is acquired with the proper sampling parameters and is re-binned by a factor of 2 in order to reject the pixel-to-pixel noise. The slope error is then measured. We considered for the verification measurements the following error sources.

Convection From Sec.3.2.1, we have that two un-correlated frames after 2 s. considering a 20 frame averaging process, we can achieve a slope RMS $\pm 0.05$ arcsec after 40s. So we can set the measurement time to 40s

Thermal drifts, vibrations The contribution is negligible (set to 0.01 arcsec) as the associated signal is mostly tilt.

Optics manufacturing This is largest contributor, even considering the correction of the interferometric cavity with parabola WF map. The high spatial scale residues of the subtraction, in facts, are responsible for a large print-through on the slope signal.

Processing error As for vibration, processing errors are negligible within this context as they are responsible for tip-tilt only.

4.4 Surface curvature error

The local curvature of the M4U optical surface after the flattening processing is requested to be larger than $80 \, \text{km}^{-1}$, in order to prevent the scalloping effect of the primary mirror segments. The spatial scale of the requirement is 80 mm, corresponding indeed to the projected size of the M1 segments on the M4U. We computed the minimum local curvature (maximum error) for each noise sources and the analysis is presented below.

Convection We can consider a time for a single un-correlated frame of 2s. After that, according to 12.1.3.2, considering a 30 frame averaging process, we can achieve curvature radius $\pm 1/1000$ Km$^{-1}$ after 60s. So we can set the measurement time to 60s.

Thermal drifts For the measurement time considered, the contribution is negligible.

Vibrations For the measurement time considered, the contribution is negligible.

Optics manufacturing The simulated manufacturing residue maps have been analyzed to compute the local curvature, showing up that the optics offset is the major contribution to this term, in particular, the print-through of the CGH.

Processing error The analysis showed that the contribution in terms of local curvature is negligible.
4.5 Surface error at the high spatial scales

After flattening and co-phasing the M4U segments, the measurement of the high spatial frequency is performed with a secondary interferometer with a 100 mm measuring beam. The goal of such additional measurement is to certify the WFE at the inter actuator scale, affected by the polishing of the shells. The measured area moves across the M4U to sample a statistically relevant number of subapertures. We recall here that the flattening procedure is performed with the LAI setup, while the verification measurement is done in SAI mode. The advantage of such a strategy is to reject (at least in part) from the verification measurements the high spatial frequency of the parabola, which is in double pass in the OTT. When switching from LAI to SAI, the PAR print-through is impressed on the M4U after the flattening procedure and will therefore give a WF signal measured on SAI. As a second point, the SAI system is insensitive to local tip-tilt at the spatial scale of 100 mm, as it is realigned at any measurement position. As a consequence, the SAI cannot measure M4U flattening offsets in the form of local tip-tilt on 100 mm patches and such contribution from LAI shall be therefore budgeted as well. We considered therefore the high frequency errors for both optical systems, namely: flattening offset at the interactuator scale from the LAI manufacturing; WF offset in the measurement from the SAI manufacturing; thermal drifts, vibrations and convections. Additionally, we needed to budget also the tip-tilt errors at the measurement scale (100 mm) as this contribution is removed with the SAI alignment.

Convection We set a 160 s of measurement time (80 measurements sampled at 0.5 Hz) and evaluated the residual convection noise on the 100 mm measurement patch, both in terms of tip-tilt offset and WFE at the interactuator scale.

Thermal drifts, vibrations We considered the higher orders beyond tip-tilt due to alignment of M4U and SAI cavity during the measurement time. The computed value is lower than 1 nm WFE so it is set to be conservative to 1 nm.

Optics manufacturing The flattening print-through at the inter-actuator scale has been evaluated on the simulated manufacturing residuals. The contribution is negligible for the manufacturing accuracy (CGH term) and approximately 5 nm RMS for the polishing precision. The local tip-tilt at the measurement spatial scale is on the opposite dominated by the CGH term, accounting for 4 nm RMS. Finally, the contribution of the SAI optics (which can be calibrated at high accuracy on the test bed) have been budgeted to 3 nm RMS.

Processing error Has been considered negligible as they account for tip-tilt residuals only.

4.6 Low order Zernike command error

The test procedure consists in the fitting of the desired Zernike shape onto each individual segment, then the command is applied and measured in push-pull. The main errors sources are described in the following:

Convection The measurement is done with a differential sampling, so that the considerations in sec.3.2.2 may be applied. The convection noise affects primarily the IF sampling, requested to fit the Zernike modes. It has been therefore considered as a noise input for the processing, described below. The sampling parameters are set as 25 frames in 1 s.

Thermal drifts, vibrations We simulated the time evolution of both thermal drifts and vibrations, sampled with differential acquisition at 25 Hz frame rate. We computed the residual noise as the average WFE of the differential frames.

Optics manufacturing This error source is not applicable as the differential sampling rejects the static offset.

Processing error the computation of the Zernike command is performed by projecting the wanted shape onto the actuators IF. The noise of the IF measurement is propagated to the final command, thus adding to the shape achieved a random error. The SNR for the low order modes is typically very good (SNR > 50), however in order to achieve a fitting error matching the REQ, the command should include the high order
modes as well. We considered three reference convection noise values for the IF measurements: 5 nm, 10 nm, 25 nm. Such values represents typical results obtained with the differential sampling (see 12.2.3). We computed the wanted Zernike commands and took the resulting shapes as fitting error references. The we re-computed the Zernike commands after injecting in the IF dataset a random noise with the given amplitudes. We then computed the difference of the shapes obtained wrt the reference ones. Thanks to this procedure, the noise of the IF is propagated throughout the command computation procedure, including the inversion of the interaction matrix.

Retrace error The discussion on this error source is fully described in Sec. 3.7.

4.7 Total error budget
The final error budget table is given below, where we report the individual contributions for all the cases discussed. The values are given (when applicable) as WFE For the curvature error, the total value has been computed by summing up the individual curvature map and the measuring the resulting shape.

<table>
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<th>Flattening</th>
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<th>Slope err.</th>
<th>Curv. err.</th>
<th>High sp. freq.</th>
<th>Zernike test</th>
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<td>arcsec</td>
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<td>nm</td>
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<td>10</td>
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<tr>
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<td>n.a.</td>
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<td>1</td>
</tr>
<tr>
<td>Opt. accuracy</td>
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<td>1/106</td>
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<td>n.a.</td>
</tr>
<tr>
<td>Processing err.</td>
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<td>n.a.</td>
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<tr>
<td>Total</td>
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<td>12</td>
<td>0.29</td>
<td>1/96</td>
<td>9</td>
<td>11 nm, 1.1% comm.</td>
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</tbody>
</table>

5. LESSON LEARNED AND REMARKS
At the end of the analysis process, we find that the error budget is within the requirements for all the measurement cases considered. We notices however some critical points that shall be carefully addressed to reduce the associated risks.

The OTT optics foot-print is a remarkable offset for the budget, in particular the nulling system used during the manufacturing of the parabola. The measurement of its low-mid spatial scales could be in principle performed on the OTT itself without a null optics, illuminating the mirror from its focus and reflecting back the collimated output with the M4 surface. The foot-print of the latter may be removed with a robust spatial averaging, i.e. by sliding and rotating the OTT structure and imaging many patches of M4. The reference flat may be used to cross-check the results, at least over patches of 60 cm diameter.

The thermal drifts have been computed starting from a temperature variation of 0.65C/hour; we considered, as a risk mitigation strategy, to wrap the OTT with insulation sheets to keep the internal temperature stable and moreover to suppress air convection during high frequency, differential samplings. Also, the location of the OTT during the calibration procedure shall be selected considering the diurnal and seasonal temperature variation of the building. Ventilation fans will be installed inside the tower to break the static air bubbles and improve the accuracy of absolute interferometric measurements (see also Sec.3.2.1).

The SPL measurement of the initial piston between adjacent segments is affected by the residual differential tilt, so that the phasing procedure will be performed in two steps: adjustment on the differential alignment and then phasing. Care shall be taken in the management of the SPL small sensing areas, so as to avoid spurious signals from local bumpiness or imperfect bavels.

As a last remark, the alignment focus from the parabola shall be accurately nulled to avoid its print-though in the actuator flattening command. This would inject a higher order spatial scale waviness on the shells as a consequence of the stress release of the glass, with a significant loss in terms of residual WFE.

We prepared a laboratory set-up to further assess some measurement cases. We named it microOTT and its final goal is to re-create a representative version of some equipment in the OTT and perform validation measurements to identify and possibly solve the related issues.
6. CONCLUSION

We presented a bottom-up approach for the measurement error budgeting of the optical calibration of M4, the E-ELT adaptive mirror. We considered the system requirements and the breakdown of the interferometric measurements requested for the verification. We identified the error sources associated with each measurement and computed their contribution. For the cases of environmental noise (e.g., air convection or thermal drifts) we converted the error budget into a sampling parameters budget, such as frame rate, number of averaged frames, in order to meet the desired accuracy. The error budget is within specifications for all the test cases: the largest contributor to WFE is the collimation optics so that an accurate measurement of its shape shall be requested. We identified the most challenging issues and set up a laboratory experimentation to validate the solutions proposed. The optical verification of the OTT will start at the beginning of 2019 and the calibration of the M4 is scheduled for 2023.

REFERENCES


